IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To be Assigned Examiner: To be Assigned

In re PATENT APPLICATION of:

: Makoto TERUI et al Applicant Appln. No. : To be Assigned Filed : Concurrently (As a Division of **INFORMATION** Application No. 10/022,268, filed **DISCLOSURE** December 20, 2001) **STATEMENT** : SEMICONDUCTOR PACKAGE AND For METHOD OF FABRICATING SAME Attorney Ref. : OKI 286 D1 March 29, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted under 37 C.F.R. §1.97 - 1.98, before issuance of the first office action on the above-identified divisional application.

A Form PTO-1449 is attached. It identifies prior art that was either submitted to or Ested by the Examiner during prosecution of the parent of the present divisional application the parent application is number 10/022,268, filed December 20, 2001). It is respectfully FEE ENCLOSED:\$ requested that the Examiner of the present divisional application consult the file of the Description for copies of the references.

It is also respectfully requested that the

It is also respectfully requested that the Examiner of the present divisional application consider the references, and indicate that this has been done by initialing each

Atty Dkt.: OKI-286 D1

reference on a copy of the attached Form PTO-1449, and returning this copy to the undersigned attorney.

Respectfully submitted,

March 29, 2004

Date

Allen Wood - Reg. No. 28,134

RABIN & BERDO, P.C.

Telephone: 202-371-8976 Telefax: 202-408-0924 CUSTOMER NO. 23995

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty. Docket	Application No.		
				OKI 286 D1	To be assigned		
				Applicant Makoto TERUI et al			
				Filing Date Concurrently (as a division of application number 10/022,268)	Group To be assigned		
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date
	AA	6,187,612	02-2001	Orcutt, John W.			_
	AB	2002/0027441	03-2002	Akram et al.			
	AC	6,392,158	05-2002	Caplet et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub- Class	Trans- lation
	A	,JP 05-036894	02-1993	Japan			
	A	JP 11-274367	10-99	Japan			
	AH	(JP 11-345899	12-99	Japan			
	AL	JP 08-306853	11-96	Japan			
	AN	JP 2000- 326144	8-00	Japan			
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AN	1					
	AC				-		
Examiner	Examiner Date Considered						
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through							
citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							